

TYPE SN54L71
AND-GATED R-S MASTER-SLAVE
FLIP-FLOPS WITH PRESET AND CLEAR
REVISED DECEMBER 1983

- Dependable Texas Instruments Quality and Reliability

description

This R-S flip-flop circuit is based on the master-slave principle. The AND gate inputs for entry into the master section are controlled by the clock pulse. The clock pulse also regulates the state of the coupling transistors which connect the master and slave sections. The sequence of operation is as follows:

1. Isolate slave from master
2. Enter information from AND gate inputs to master
3. Disable AND gate inputs
4. Transfer information from master to slave

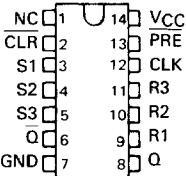
The SN54L71 is characterized for operation over the full military temperature range of - 55°C to 125°C.

FUNCTION TABLE

INPUTS					OUTPUTS	
PRE	CLR	CLK	S	R	Q	$\bar{Q}$
L	H	X	X	X	H	L
H	L	X	X	X	L	H
L	L	X	X	X	H [†]	H [†]
H	H		L	L	Q ₀	$\bar{Q}_0$
H	H		H	L	H	L
H	H		L	H	L	H
H	H		H	H	INDETERMINATE	

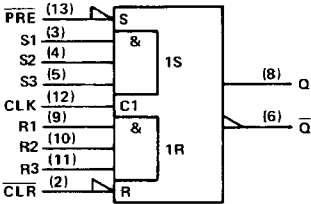
† This configuration is nonstable; that is, it will not persist when preset and clear inputs return to their inactive (high) level.

SN54L71 ... J PACKAGE
(TOP VIEW)



NC - No internal connection

logic symbol



Pin numbers shown are for J packages.

positive logic

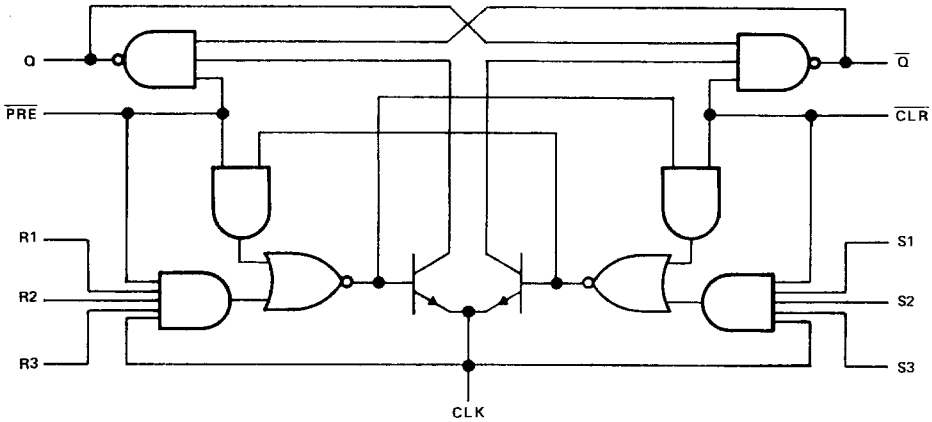
$$R = R1 \cdot R2 \cdot R3$$
$$S = S1 \cdot S2 \cdot S3$$

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TYPE SN54L71 AND-GATED R-S MASTER-SLAVE FLIP-FLOPS WITH PRESET AND CLEAR

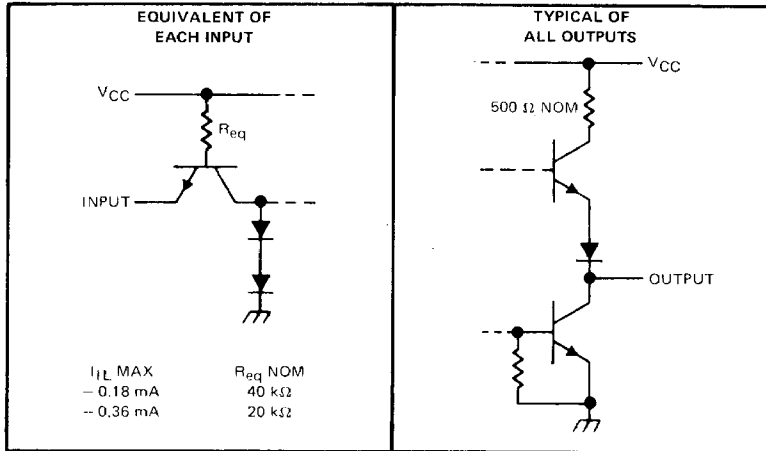
logic diagram



schematics of input and outputs

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1)	7 V
Input voltage	5.5 V
Operating free-air temperature	− 55°C to 125°C
Storage temperature range	− 65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

	MIN	NOM	MAX	UNIT
V_{CC} Supply voltage	4.5	5	5.5	V
V_{IH} High-level input voltage	2			V
V_{IL} Low-level input voltage			0.6	V
			0.7	
I_{OH} High-level output current			− 0.1	mA
I_{OL} Low-level output current			2	mA
t_w Pulse duration	CLK high or low	200		ns
	PRE or CLR low	100		
t_{su} Setup time before CLK $\uparrow$	0			ns
t_h Hold time-data after CLK $\downarrow$	0			ns
T_A Operating free-air temperature	− 55		125	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS $\uparrow$	MIN	TYP $\ddagger$	MAX	UNIT
V_{OH}	$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, V_{IL} = \text{MAX}, I_{OH} = -0.1 \text{ mA}$	2.4	3.3		V
V_{OL}	$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, V_{IL} = \text{MAX}, I_{OL} = 2 \text{ mA}$		0.15	0.3	V
I_I	R or S			0.1	mA
	All other			0.2	
I_{IH}	R or S			10	μA
	PRE or CLR			20	
	CLK			− 0.2	mA
I_{IL}	R or S			− 0.18	mA
	All other			− 0.36	
I_{QS}	$V_{CC} = \text{MAX}$	− 3		− 15	mA
I_{CC}	$V_{CC} = \text{MAX}, \text{ See Note 2}$		0.76	1.44	mA

$\uparrow$ For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.
 $\ddagger$ All typical values are at $V_{CC} = 5 \text{ V}, T_A = 25^\circ\text{C}$.
NOTE 2: With all outputs open, I_{CC} is measured with the Q and $\bar{Q}$ outputs high in turn. At the time of measurement, the clock input is grounded.

switching characteristics, $V_{CC} = 5 \text{ V}, T_A = 25^\circ\text{C}$ (see note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS		MIN	TYP	MAX	UNIT
$f_{\max}$			$R_L = 4\text{ k}\Omega, \quad C_L = 50\text{ pF}$		2.5	3		MHz
t_{PLH}	PRE or CLR	Q or $\bar{Q}$				35	75	ns
t_{PHL}	PRE or CLR (CLK high)	$\bar{Q}$ or Q				60	150	ns
	PRE or CLR (CLK low)						200	
t_{PLH}	CLK	Q or $\bar{Q}$				10	35	75
t_{PHL}				10	60	150		

NOTE 3 : See General Information Section for load circuits and voltage waveforms.

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